



# CERTIFICATE OF ACCREDITATION

**The ANSI National Accreditation Board**

Hereby attests that

**Transcat – New England**  
149 River Street, Suite 3  
Andover, MA 01810

Fulfills the requirements of

**ISO/IEC 17025:2017**

and national standards

**ANSI/NCSL Z540-1-1994 (R2002) AND**  
**ANSI/NCSL Z540.3-2006 (R2013)**

In the field of

**CALIBRATION AND DIMENSIONAL MEASUREMENT**

This certificate is valid only when accompanied by a current scope of accreditation document.  
The current scope of accreditation can be verified at [www.anab.org](http://www.anab.org).

Jason Stine, Vice President

Expiry Date: 07 September 2025  
Certificate Number: AC-2489.04



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.  
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory  
quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

**SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017**

**AND**

**ANSI/NCSL Z540-1-1994 (R2002)**  
**ANSI/NCSL Z540.3-2006 (R2013)**

**Transcat – New England**

149 River Street, Suite 3  
Andover, MA 01810  
Zachary Curry-Brown 978-988-3910

**CALIBRATION AND DIMENSIONAL MEASUREMENT**

Valid to: September 7, 2025

Certificate Number: AC-2489.04

**CALIBRATION**

**Chemical Quantities**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
pH – Measuring Equipment <sup>1</sup>	4 pH 7 pH 10 pH	0.011 pH 0.01 pH 0.012 pH	Standard Buffer Solutions

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source <sup>1</sup>	Up to 220 $\mu$ A (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (0.22 to 2.2) mA (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.031 % of reading + 16 nA 0.019 % of reading + 10 nA 0.015 % of reading + 8 nA 0.03 % of reading + 12 nA 0.11 % of reading + 65 nA  0.03 % of reading + 40 nA 0.018 % of reading + 35 nA 0.014 % of reading + 35 nA 0.021 % of reading + 0.11 $\mu$ A 0.11 % of reading + 0.65 $\mu$ A	Fluke 5720A Multiproduct Calibrator

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source <sup>1</sup>	(2.2 to 22) mA		Fluke 5720A Multiproduct Calibrator
	(10 to 20) Hz	0.039 % of reading + 0.4 μA	
	(20 to 40) Hz	0.019 % of reading + 0.35 μA	
	40 Hz to 1 kHz	0.014 % of reading + 0.35 μA	
	(1 to 5) kHz	0.021 % of reading + 0.55 μA	
	(5 to 10) kHz	0.11 % of reading + 5 μA	
	(22 to 220) mA		
	(10 to 20) Hz	0.033 % of reading + 4 μA	
	(20 to 40) Hz	0.018 % of reading + 3.5 μA	
	40 Hz to 1 kHz	0.014 % of reading + 2.5 μA	
	(1 to 5) kHz	0.021 % of reading + 3.5 μA	
	(5 to 10) kHz	0.11 % of reading + 10 μA	
AC Current – Source <sup>1</sup>	(0.22 to 2.2) A		Fluke 5720A Multiproduct Calibrator, Fluke 5725A Amplifier
	20 Hz to 1 kHz	0.027 % of reading + 35 μA	
	(1 to 5) kHz	0.046 % of reading + 80 μA	
	(5 to 10) kHz	0.7 % of reading + 0.16 mA	
	(2.2 to 11) A		
	40 Hz to 1 kHz	0.048 % of reading + 0.17 mA	
(1 to 5) kHz	0.096 % of reading + 0.38 mA		
(5 to 10) kHz	0.36 % of reading + 0.75 mA		
AC Current – Source <sup>1</sup>	(11 to 20.5) A		Two Fluke 5520 Multiproduct Calibrators in Parallel
	(45 to 100) Hz	0.11 % of reading + 3.9 mA	
	100 Hz to 1 kHz	0.14 % of reading + 3.9 mA	
	(1 to 5) kHz	2.7 % of reading + 3.9 mA	
AC Current – Source <sup>1</sup>	(20.5 to 40)		Fluke 5520A Multiproduct Calibrator, Valhalla 2555A Amplifier
	(45 to 100) Hz	0.14 % of reading + 11 mA	
	100 Hz to 1 kHz	0.17 % of reading + 11 mA	
	(1 to 5) kHz	3.3 % of reading + 11 mA	
AC Current – Source <sup>1</sup>	(40 to 100) A		Fluke 5520A Multiproduct Calibrator
	(50 to 100) Hz	0.12 % of reading + 0.35 A	
	100 Hz to 1 kHz	0.24 % of reading + 0.47 A	
	(1 to 5) kHz	0.35 % of reading + 0.7 A	
AC Current – Source <sup>1</sup> (Extended Frequency Ranges)	(29 to 330) μA		Fluke 5520A Multiproduct Calibrator
	(10 to 30) kHz	1.5 % of reading + 0.31 μA	
	(0.33 to 3.3) mA		
	(10 to 30) kHz	0.92 % of reading + 0.47 μA	
	(3.3 to 33) mA		
	(10 to 30) kHz	0.37 % of reading + 3.1 μA	
(29 to 330) mA			
(10 to 30) kHz	0.37 % of reading + 0.16 mA		



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Clamp-on Ammeters (Toroidal Type) Transformer Type Sensor <sup>1</sup>	(20 to 150) A (45 to 65) Hz (65 to 440) Hz (150 to 1 000) A (45 to 65) Hz (65 to 440) Hz	0.35 % of reading + 0.25 A 0.94 % of reading + 50 µA 0.34 % of reading + 0.13 A 1.2 % of reading + 0.23 A	Fluke 5522A Multiproduct Calibrator, 5500A/COIL 50-turn Coil
AC Clamp-on Ammeters (Non-Toroidal Type) Hall Effect Sensor <sup>1</sup>	(20 to 150) A (45 to 65) Hz (65 to 440) Hz (150 to 1 000) A (45 to 65) Hz (65 to 440) Hz	0.6 % of reading + 0.29 A 1 % of reading + 0.29 A 0.57 % of reading + 1 A 1.3 % of reading + 1.1 A	Fluke 5522A Multiproduct Calibrator, 5500A/COIL 50-turn Coil
AC Current – Measure <sup>1</sup>	Up to 100 µA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 1 kHz (0.1 to 1) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (1 to 10) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (10 to 100) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (0.1 to 1) A (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % of reading + 35 nA 0.18 % of reading + 35 nA 0.072 % of reading + 35 nA 0.072 % of reading + 35 nA 0.46 % of reading + 0.23 µA 0.17 % of reading + 0.23 µA 0.07 % of reading + 0.23 µA 0.038 % of reading + 0.23 µA 0.46 % of reading + 2.3 µA 0.17 % of reading + 2.3 µA 0.07 % of reading + 2.3 µA 0.038 % of reading + 2.3 µA 0.46 % of reading + 23 µA 0.17 % of reading + 23 µA 0.07 % of reading + 23 µA 0.037 % of reading + 23 µA 0.46 % of reading + 0.23 mA 0.19 % of reading + 0.23 mA 0.096 % of reading + 0.23 mA 0.12 % of reading + 0.23 mA	Agilent 3458A/002 8.5 Digit Multimeter

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Measure <sup>1</sup>	(1 to 3) A 40 Hz to 1 kHz (1 to 5) kHz	0.18 % of reading + 2.1 mA 0.2 % of reading + 2.1 mA	Agilent 3458A/002 8.5 Digit Multimeter, Agilent 34330A Current Shunt
	(3 to 30) A 40 Hz to 1 kHz (1 to 5) kHz	0.35 % of reading + 2.3 mA 5.8 % of reading + 2.3 mA	
DC Current – Source <sup>1</sup>	(0.22 to 220) $\mu$ A	41 $\mu$ A/A + 6 nA	Fluke 5700A/EP Multiproduct Calibrator
	(0.22 to 2.2) mA	36 $\mu$ A/A + 7 nA	
	(2.2 to 22) mA	35 $\mu$ A/A + 40 nA	
	(22 to 220) mA	48 $\mu$ A/A + 0.7 $\mu$ A	
	(0.22 to 2.2) A	0.2 mA/A + 12 $\mu$ A	
DC Current – Source <sup>1</sup>	(2.2 to 11) A	0.4 mA/A + 12 $\mu$ A	Fluke 5700A/EP Multiproduct Calibrator, Fluke 5725A Amplifier
DC Current – Source <sup>1</sup>	(11 to 20.5) A	0.84 mA/A + 0.58 mA	Fluke 5520A/11 Multiproduct Calibrator
DC Current – Source <sup>1</sup>	(20.5 to 40) A	0.12 % of reading + 0.82 mA	Two Fluke 5520 Multiproduct Calibrators in Parallel
DC Current – Source <sup>1</sup>	(40 to 100) A	0.037 % of reading + 35 mA	Fluke 5520A Multiproduct Calibrator, Valhalla 2555A Amplifier
DC Clamp-on Ammeters (Non-Toroidal Type) Transformer Type Sensor <sup>1</sup>	(20 to 150) A (150 to 1 000) A	0.51 % of reading + 0.14 A 0.51 % of reading + 0.5 A	Fluke 5520A Multiproduct Calibrator, 5500A/COIL 50-turn Coil
DC Current – Source/Measure <sup>1</sup>	Up to 100 $\mu$ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	33 $\mu$ A/A + 0.92 nA 29 $\mu$ A/A + 5.8 nA 29 $\mu$ A/A + 58 nA 46 $\mu$ A/A + 0.58 $\mu$ A 0.013 % of reading + 12 $\mu$ A	Agilent 3458A/002 8.5 Digit Multimeter w/ Current Source



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Current – Measure <sup>1</sup>	Up to 10 $\mu$ A (10 to 100) $\mu$ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	0.13 mA/A + 58 pA 0.12 mA/A + 0.58 nA 0.12 mA/A + 5.8 nA 0.12 mA/A + 58 nA 0.12 mA/A + 0.58 $\mu$ A 0.12 mA/A + 5.8 $\mu$ A	Agilent 3458A/002 8.5 Digit Multimeter
DC Current – Measure <sup>1</sup>	(1 to 10) A (10 to 100) A (100 to 300) A	0.14 mA/A + 58 $\mu$ A 0.59 mA/A + 0.58 mA 0.12 % of reading + 1.7 mA	Guideline 9711A Current Shunt, Agilent 3458A/002 8.5 Digit Multimeter
DC Current – Measure <sup>1</sup>	(300 to 1 000) A	0.12 % of reading + 5.8 mA	Meterman 1000-100 Current Shunt, Agilent 3458A/002 8.5 Digit Multimeter
AC Voltage – Source <sup>1</sup>	Up to 2.2 mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz (2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz (22 to 220) mV (10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.16 % of reading + 4 $\mu$ V 0.1 % of reading + 4 $\mu$ V 0.078 % of reading + 4 $\mu$ V 0.13 % of reading + 4 $\mu$ V 0.17 % of reading + 5 $\mu$ V 0.33 % of reading + 10 $\mu$ V 0.47 % of reading + 20 $\mu$ V 0.58 % of reading + 20 $\mu$ V 0.042 % of reading + 4 $\mu$ V 0.03 % of reading + 4 $\mu$ V 0.014 % of reading + 4 $\mu$ V 0.03 % of reading + 4 $\mu$ V 0.058 % of reading + 5 $\mu$ V 0.12 % of reading + 10 $\mu$ V 0.16 % of reading + 20 $\mu$ V 0.27 % of reading + 20 $\mu$ V 0.028 % of reading + 12 $\mu$ V 0.011 % of reading + 7 $\mu$ V 0.008 5 % of reading + 7 $\mu$ V 0.021 % of reading + 7 $\mu$ V 0.047 % of reading + 17 $\mu$ V 0.091 % of reading + 20 $\mu$ V 0.14 % of reading + 25 $\mu$ V 0.28 % of reading + 45 $\mu$ V	Fluke 5720A Multiproduct Calibrator



**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source <sup>1</sup>	(0.22 to 2.2) V		Fluke 5720A Multiproduct Calibrator
	(10 to 20) Hz	0.027 % of reading + 40 μV	
	(20 to 40) Hz	0.01 % of reading + 15 μV	
	40 Hz to 20 kHz	0.004 8 % of reading + 8 μV	
	(20 to 50) kHz	0.008 % of reading + 10 μV	
	(50 to 100) kHz	0.012 % of reading + 30 μV	
	(100 to 300) kHz	0.043 % of reading + 80 μV	
	(300 to 500) kHz	0.1 % of reading + 0.2 mV	
	500 kHz to 1 MHz	0.18 % of reading + 0.3 mV	
	(2.2 to 22) V		
	(10 to 20) Hz	0.028 % of reading + 0.4 mV	
	(20 to 40) Hz	0.01 % of reading + 0.15 mV	
	40 Hz to 20 kHz	0.004 9 % of reading + 50 μV	
	(20 to 50) kHz	0.008 3 % of reading + 0.1 mV	
	(50 to 100) kHz	0.012 % of reading + 0.2 mV	
	(100 to 300) kHz	0.03 % of reading + 0.6 mV	
	(300 to 500) kHz	0.1 % of reading + 2 mV	
	500 kHz to 1 MHz	0.17 % of reading + 3.2 mV	
AC Voltage – Source <sup>1</sup>	(22 to 220) V		Fluke 5720A Multiproduct Calibrator, Fluke 5725A Amplifier
	(10 to 20) Hz	0.028 % of reading + 4 mV	
	(20 to 40) Hz	0.01 % of reading + 1.5 mV	
	40 Hz to 20 kHz	0.005 6 % of reading + 0.6 mV	
	(20 to 50) kHz	0.009 3 % of reading + 1 mV	
	(50 to 100) kHz	0.016 % of reading + 2.5 mV	
	(100 to 300) kHz	0.09 % of reading + 16 mV	
	(300 to 500) kHz	0.44 % of reading + 40 mV	
	500 kHz to 1 MHz	0.8 % of reading + 40 mV	
	(220 to 750) V		
	(30 to 50) kHz	0.061 % of reading + 11 mV	
	(50 to 100) kHz	0.23 % of reading + 45 mV	
(220 to 1 100) V			
40 Hz to 1 kHz	0.011 % of reading + 4 mV		
(1 to 20) kHz	0.017 % of reading + 6 mV		
(20 to 30) kHz	0.061 % of reading + 11 mV		



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure <sup>1</sup>	Up to 10 mV		Agilent 3458A/002 8.5 Digit Multimeter
	(1 to 40) Hz	0.04 % of reading + 3.5 μV	
	40 Hz to 1 kHz	0.03 % of reading + 1.2 μV	
	(1 to 20) kHz	0.04 % of reading + 1.2 μV	
	(20 to 50) kHz	0.15 % of reading + 1.2 μV	
	(50 to 100) kHz	0.59 % of reading + 1.2 μV	
	(100 to 300) kHz	4.6 % of reading + 2.3 μV	
	300 kHz to 1 MHz	1.5 % of reading + 5.8 μV	
	1 MHz to 4 MHz	8.1 % of reading + 8.1 μV	
	(10 to 100) mV		
	(1 to 40) Hz	0.013 % of reading + 4.6 μV	
	40 Hz to 1 kHz	0.009 7 % of reading + 2.3 μV	
	(1 to 20) kHz	0.017 % of reading + 2.3 μV	
	(20 to 50) kHz	0.038 % of reading + 2.3 μV	
	(50 to 100) kHz	0.093 % of reading + 2.3 μV	
	(100 to 300) kHz	0.36 % of reading + 12 μV	
	300 kHz to 1 MHz	1.2 % of reading + 12 μV	
	(1 to 2) MHz	1.8 % of reading + 12 μV	
	(2 to 4) MHz	4.7 % of reading + 81 μV	
	(4 to 8) MHz	4.7 % of reading + 92 μV	
	(8 to 10) MHz	17 % of reading + 0.12 mV	
	(0.1 to 1) V		
	(1 to 40) Hz	0.008 8 % of reading + 46 μV	
	40 Hz to 1 kHz	0.008 3 % of reading + 23 μV	
(1 to 20) kHz	0.017 % of reading + 23 μV		
(20 to 50) kHz	0.036 % of reading + 23 μV		
(50 to 100) kHz	0.093 % of reading + 23 μV		
(100 to 300) kHz	0.35 % of reading + 0.12 mV		
300 kHz to 1 MHz	1.2 % of reading + 0.12 mV		
(1 to 2) MHz	1.8 % of reading + 0.12 mV		
(2 to 4) MHz	4.6 % of reading + 0.81 mV		
(4 to 8) MHz	4.6 % of reading + 0.92 mV		
(8 to 10) MHz	17 % of reading + 1.2 mV		





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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure <sup>1</sup>	(1 to 10) V		Agilent 3458A/002 8.5 Digit Multimeter
	(1 to 40) Hz	0.009 5 % of reading + 0.46 mV	
	40 Hz to 1 kHz	0.023 % of reading + 0.23 mV	
	(1 to 20) kHz	0.017 % of reading + 0.23 mV	
	(20 to 50) kHz	0.036 % of reading + 0.23 mV	
	(50 to 100) kHz	0.093 % of reading + 0.23 mV	
	(100 to 300) kHz	0.35 % of reading + 1.2 mV	
	300 kHz to 1 MHz	1.2 % of reading + 1.2 mV	
	(1 to 2) MHz	1.8 % of reading + 1.2 mV	
	(2 to 4) MHz	4.6 % of reading + 8.1 mV	
	(4 to 8) MHz	4.6 % of reading + 9.2 mV	
	(8 to 10) MHz	17 % of reading + 12 mV	
	(10 to 100) V		
	(1 to 40) Hz	0.024 % of reading + 4.6 mV	
	40 Hz to 1 kHz	0.024 % of reading + 2.3 mV	
(1 to 20) kHz	0.024 % of reading + 2.3 mV		
(20 to 50) kHz	0.041 % of reading + 2.3 mV		
(50 to 100) kHz	0.14 % of reading + 2.3 mV		
(100 to 300) kHz	0.46 % of reading + 12 mV		
300 kHz to 1 MHz	1.7 % of reading + 12 mV		
(100 to 700) V			
(1 to 40) Hz	0.048 % of reading + 46 mV		
40 Hz to 1 kHz	0.048 % of reading + 23 mV		
(1 to 20) kHz	0.071 % of reading + 23 mV		
(20 to 50) kHz	0.19 % of reading + 23 mV		
(50 to 100) kHz	0.35 % of reading + 23 mV		
AC Voltage – Measure <sup>1</sup>	Up to 1 mV		Rohde & Schwarz URE3 RMS Voltmeter
	100 kHz to 1 MHz	2 % of reading + 2.4 μV	
	(1 to 3) MHz	3.8 % of reading + 2.4 μV	
	(3 to 10) MHz	10 % of reading + 2.4 μV	
	(10 to 20) MHz	25 % of reading + 2.4 μV	
	(1 to 3) mV		
	100 kHz to 1 MHz	1 % of reading + 2 μV	
	(1 to 3) MHz	3.8 % of reading + 2 μV	
	(3 to 10) MHz	11 % of reading + 2 μV	
	(10 to 20) MHz	25 % of reading + 2 μV	

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure <sup>1</sup>	(3 to 100) mV 100 kHz to 1 MHz (1 to 3) MHz (3 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.98 % of reading + 3 μV 1.9 % of reading + 3 μV 3.2 % of reading + 3 μV 7.6 % of reading + 3 μV 16 % of reading + 3 μV	Rohde & Schwarz URE3 RMS Voltmeter
AC High Voltage – Measure <sup>1</sup>	(0.7 to 10) kV 60 Hz	0.14 % of reading	Vitrek 4700 High Voltage Meter
AC High Voltage – Measure <sup>1</sup>	(10 to 30) kV 60 Hz	0.095 % of reading + 17 V	Vitrek 4700 High Voltage Meter, Vitrek HVP-35 High Voltage Probe
AC High Voltage – Measure <sup>1</sup>	(30 to 50) kV 60 Hz	0.16 % of reading + 4 V	Vitrek 4700 High Voltage Meter, Vitrek HVP-70 High Voltage Probe
AC High Voltage – Measure <sup>1</sup>	(50 to 70) kV 60 Hz	0.23 % of reading + 1.4 V	Vitrek 4700 High Voltage Meter, Vitrek HVP-100 High Voltage Probe
DC Voltage – Source <sup>1</sup>	(0 to 220) mV (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V	8.5 μV/V + 0.4 μV 5.1 μV/V + 0.7 μV 4 μV/V + 2.5 μV 3.9 μV/V + 4 μV 6.2 μV/V + 40 μV	Fluke 5720A Multiproduct Calibrator
DC Voltage – Source <sup>1</sup>	220 V to 1.1 kV	7.6 μV/V + 0.4 mV	Fluke 5720A Multiproduct Calibrator, Fluke 5725A Amplifier
DC Voltage – Measure <sup>1</sup>	(0 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 500) V (500 to 800) V (800 to 1 000) V	8.3 μV/V + 0.58 μV 5.3 μV/V + 0.58 μV 5.3 μV/V + 0.58 μV 7.7 μV/V + 35 μV 15 μV/V + 0.12 mV 18 μV/V + 0.12 mV 21 μV/V + 0.12 mV	Agilent 3458A/002 8.5 Digit Multimeter
DC High Voltage – Measure <sup>1</sup>	(1 to 10) kV	0.054 % of reading	Vitrek 4700 High Voltage Meter

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC High Voltage – Measure <sup>1</sup>	(10 to 35) kV	0.093 % of reading	Vitretek 4700 High Voltage Meter, Vitretek HVP-35 High Voltage Probe
DC High Voltage – Measure <sup>1</sup>	(35 to 70) kV	0.11 % of reading + 8.1 V	Vitretek 4700 High Voltage Meter, Vitretek HVP-70 High Voltage Probe
DC High Voltage – Measure <sup>1</sup>	(70 to 100) kV	0.17 % of reading + 1.3 V	Vitretek 4700 High Voltage Meter, Vitretek HVP-100 High Voltage Probe
Resistance – Source <sup>1</sup> (Artifact)	333 μΩ 1 mΩ 10 mΩ 100 mΩ 1 Ω 10 Ω 100 Ω 1 kΩ 10 kΩ	0.12 % of reading 0.59 mΩ/Ω 0.14 mΩ/Ω 0.12 mΩ/Ω 0.12 mΩ/Ω 0.12 mΩ/Ω 0.12 mΩ/Ω 0.12 mΩ/Ω 0.13 mΩ/Ω	Guideline 9711A Multi-tap Current Shunt
Resistance – Source <sup>1</sup> (Fixed Artifact)	25 Ω	9.4 μΩ/Ω	IET SRL-25 Standard Resistor
Resistance – Source <sup>1,2</sup> (Variable Artifact)	(0.1 to 1) MΩ (1 to 10) MΩ (10 to 100) MΩ (0.1 to 1) GΩ (1 to 10) GΩ (10 to 100) GΩ (0.1 to 1) TΩ	0.18 % of reading + 2.3 Ω 0.21 % of reading + 120 Ω + 1.2 Ω/V 0.22 % of reading + 1.2 kΩ + 12 Ω/V 0.3 % of reading + 32 kΩ + 0.12 kΩ/V 0.58 % of reading + 0.48 MΩ + 1.2 kΩ/V 1.2 % of reading + 62 MΩ + 23 kΩ/V 2.6 % of reading + 15 GΩ + 0.58 MΩ/V	IET HRRS-B-7-100k-5kV High Resistance Decade Box
Resistance – Source/Measure <sup>1</sup>	Up to 10 Ω (10 to 100) Ω (0.1 to 1) kΩ (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ (10 to 100) MΩ (0.1 to 1) GΩ	18 μΩ/Ω + 58 μΩ 15 μΩ/Ω + 0.58 mΩ 12 μΩ/Ω + 0.58 mΩ 12 μΩ/Ω + 5.8 mΩ 13 μΩ/Ω + 58 mΩ 21 μΩ/Ω + 2.3 Ω 62 μΩ/Ω + 0.12 kΩ 0.059 % of reading + 1.2 kΩ 0.82 % of reading + 12 kΩ	Decade Resistance Box, HP 3458A 8.5 Digit Multimeter



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Resistance – Measure <sup>1</sup>	Up to 1 Ω (1 to 10) Ω 10 Ω to 10 kΩ (10 to 40) kΩ (40 to 100) kΩ (100 to 500) kΩ	42 μΩ/Ω + 30 nΩ 16 μΩ/Ω 13 μΩ/Ω 16 μΩ/Ω 23 μΩ/Ω 81 μΩ/Ω	Fluke 1595A Super Thermometer
AC Resistance – Measure <sup>1</sup>	1 kHz Up to 6.25 Ω 6.25 Ω to 100 kΩ (100 to 410) kΩ	0.7 % of reading + 10 mΩ 0.024 % of reading + 10 mΩ 0.3 % of reading + 10 mΩ	General Radio 1689-9700 LCR Meter
Capacitance – Source <sup>1,3</sup> (Artifacts)	100 Hz to 1 kHz (0.1 to 0.5) nF 0.5 nF to 1.4 μF	0.58 pF 0.12 % of reading + 0.02 pF	Arco SS32 Precision Standard Capacitor Set
Capacitance – Source <sup>1</sup> (Simulation)	10 Hz to 10 kHz (0.19 to 3.3) pF 10 Hz to 1 kHz (3.3 to 11) nF (11 to 110) nF (110 to 330) nF (10 to 600) Hz (0.33 to 1.1) μF (10 to 300) Hz (1.1 to 3.3) μF (10 to 150) Hz (3.3 to 11) μF (10 to 120) Hz (11 to 33) μF (10 to 80) Hz (33 to 110) μF DC to 50 Hz (110 to 330) μF DC to 20 Hz (0.33 to 1.1) mF DC to 6 Hz (1.1 to 3.3) mF DC to 2 Hz (3.3 to 11) mF DC to 0.6 Hz (11 to 33) mF DC to 0.2 Hz (33 to 110) mF	0.39 % of reading + 6.1 pF 0.21 % of reading + 6.1 pF 0.21 % of reading + 61 pF 0.21 % of reading + 0.18 nF 0.2 % of reading + 0.61 nF 0.2 % of reading + 1.9 nF 0.2 % of reading + 6.1 nF 0.32 % of reading + 18 nF 0.35 % of reading + 61 nF 0.35 % of reading + 0.18 μF 0.35 % of reading + 0.61 μF 0.35 % of reading + 1.8 μF 0.35 % of reading + 6.1 μF 0.58 % of reading + 18 μF 0.85 % of reading + 61 μF	Fluke 5520A Multiproduct Calibrator



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Capacitance – Measure <sup>1</sup>	1 kHz (1 to 10) pF (10 to 100) pF (0.1 to 1) μF (1 to 100) μF (0.1 to 1) mF	0.47 % of reading + 0.05 pF 0.058 % of reading + 0.05 pF 0.024 % of reading + 0.05 pF 0.035 % of reading 0.24 % of reading	GR 1689-9700 Precision Impedance Meter
Inductance – Source <sup>1</sup> (Artifacts)	1 kHz 50 mH 100 mH	0.12 % of reading + 1.4 μH 0.12 % of reading + 1.4 μH	Standard Inductors
Inductance – Measure <sup>1</sup>	1 kHz (1 to 10) mH 10 mH to 10 H	0.024 % of reading + 0.1 μH 0.024 % of reading + 1.4 μH	GR 1689-9700 Precision Impedance Meter
Electrical Simulation of Thermocouple Indicating Devices – Measure/Source <sup>1</sup>	Type E (-270 to -245) °C (-245 to -195) °C (-195 to -155) °C (-155 to -90) °C (-90 to 0) °C (0 to 15) °C (15 to 890) °C (890 to 1 000) °C Type J (-210 to -180) °C (-180 to -120) °C (-120 to -50) °C (-50 to 990) °C (990 to 1 200) °C Type K (-270 to -255) °C (-255 to -195) °C (-195 to -115) °C (-115 to -55) °C (-55 to 1 000) °C (1 000 to 1 372) °C	1.6 °C 0.24 °C 0.12 °C 0.095 °C 0.08 °C 0.076 °C 0.064 °C 0.074 °C 0.15 °C 0.12 °C 0.093 °C 0.08 °C 0.094 °C 2.5 °C 0.85 °C 0.16 °C 0.12 °C 0.087 °C 0.096 °C	Ectron 1140A Thermocouple Calibrator/Simulator



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Electrical Simulation of Thermocouple Indicating Devices – Measure/Source <sup>1</sup>	Type N		Ectron 1140A Thermocouple Calibrator/Simulator
	(-270 to -260) °C	5.4 °C	
	(-260 to -200) °C	1.5 °C	
	(-200 to -140) °C	0.29 °C	
	(-140 to -70) °C	0.18 °C	
	(-70 to -25) °C	0.14 °C	
	(-25 to 160) °C	0.12 °C	
	(160 to 1 300) °C	0.11 °C	
	Type R		
	(-50 to -30) °C	0.8 °C	
	(-30 to 45) °C	0.69 °C	
	(45 to 160) °C	0.49 °C	
	(160 to 380) °C	0.35 °C	
	(380 to 775) °C	0.3 °C	
	(775 to 1 768) °C	0.26 °C	
	Type S		
	(-50 to -30) °C	0.76 °C	
	(-30 to 45) °C	0.68 °C	
	(45 to 105) °C	0.49 °C	
	(105 to 310) °C	0.41 °C	
	(310 to 615) °C	0.35 °C	
(615 to 1 768) °C	0.31 °C		
Type T			
(-270 to -255) °C	1.9 °C		
(-255 to -240) °C	0.6 °C		
(-240 to -210) °C	0.36 °C		
(-210 to -150) °C	0.22 °C		
(-150 to -40) °C	0.15 °C		
(-40 to 100) °C	0.095 °C		
(100 to 400) °C	0.08 °C		



**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment	
AC Power – Source <sup>1,4</sup> PF = 1				
(3.3 to 9) mA	(10 to 65) Hz (0.11 mW to 3) mW 3 mW to 9 W	0.13 % of reading 0.077 % of reading	Fluke 5520A Multiproduct Calibrator	
(9 to 33) mA	(10 to 65) Hz (0.3 to 10) mW 10 mW to 33 W	0.089 % of reading 0.077 % of reading		
(33 to 90) mA	(10 to 65) Hz (1 to 30) mW 30 mW to 90 W	0.071 % of reading 0.057 % of reading		
(90 to 330) mA	(10 to 65) Hz (3 to 100) mW 100 mW to 300 W	0.089 % of reading 0.078 % of reading		
(0.33 to 0.9) A	(10 to 65) Hz (11 to 300) mW (0.3 to 900) W	0.071 % of reading 0.081 % of reading		
(0.9 to 2.2) A	(10 to 65) Hz (30 to 720) mW 0.72 W to 2 kW	0.089 % of reading 0.079 % of reading		
(2.2 to 4.5) A	(10 to 65) Hz 80 mW to 1.4 W 1.4 W to 4.5 kW	0.088 % of reading 0.18 % of reading		
(4.5 to 20.5) A	(10 to 65) Hz 150 mW to 20 kW	0.17 % of reading		
DC Power – Source <sup>1</sup> (0.33 to 330) mA	11 μW to 1.1 mW 1.1 mW to 0.11 W (0.11 to 110) W (110 to 330) W	0.024 % of reading 0.027 % of reading 0.024 % of reading 0.018 % of reading		Fluke 5520A Multiproduct Calibrator
(0.33 to 3) A	11 μW to 110 mW (0.11 to 990) W (0.99 to 3) kW	0.044 % of reading 0.053 % of reading 0.009 6 % of reading		
(3 to 20.5) A	99 mW to 0.99 W 0.99 W to 6.8 kW (6.8 to 20.5) kW	0.088 % of reading 0.07 % of reading 0.04 % of reading		



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Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Phase – Source <sup>1</sup>	Up to 180° (10 to 65) Hz (65 to 500) Hz 500 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 20) kHz	0.11° 0.2° 0.4° 1.9° 3.9° 7.8°	Fluke 5520A Multiproduct Calibrator
Oscilloscopes <sup>1,5,6</sup> Amplitude DC into 50 Ω load into 1 MΩ load  Square Wave into 50 Ω load  into 1 MΩ load  Time Markers into 50 Ω load  Rise Time – Source into 50 Ω load Rate: 1 kHz to 2 MHz Rate: 2 MHz to 10 MHz	(-6 to 6) V (-130 to 130) V  10 Hz to 100 kHz 1 mV p-p to 6.6 Vp-p  10 Hz to 1 kHz 1 mV p-p to 130 Vp-p (1 kHz to 10) kHz 1 mV p-p to 130 Vp-p  1 ns to 20 ms 50 ms 0.1 s 0.2 s 0.5 s 1 s 2 s 5 s  5 mVp-p to 2.5 Vp-p 250 ps (nominal) 250 ps (nominal)	0.22 % of reading + 31 μV 0.12 % of reading + 31 μV  0.22 % of reading + 31 μV  0.14 % of reading + 31 μV 0.22 % of reading + 31 μV  0.000 2 % of reading 2.3 μs 7.6 μs 28 μs 0.16 ms 0.62 ms 2.4 ms 15 ms  50 ps 50 ps	Fluke 5520A/11 Multiproduct Calibrator with 1.1 GHz Scope Option

**Electrical – DC/Low Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Oscilloscopes <sup>1,5,6</sup> Leveled Sine Wave into 50 Ω load	5 mVp-p to 5.5 Vp-p 50 kHz 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz 5 mVp-p to 3.5 Vp-p (600 to 1 100) MHz	1.8 % of reading + 0.23 mV 2.8 % of reading + 0.23 mV 3.2 % of reading + 0.23 mV 4 % of reading + 0.23 mV 5.5 % of reading + 0.23 mV	Fluke 5520A/11 Multiproduct Calibrator with 1.1 GHz Scope Option
Bandwidth/Flatness (50 kHz Reference) into 50 Ω load	5 mVp-p to 5.5 Vp-p 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz 5 mVp-p to 3.5 Vp-p (600 to 1 100) MHz	1.4 % of reading + 78 μV 1.8 % of reading + 78 μV 3.2 % of reading + 78 μV 4 % of reading + 78 μV	
Input Impedance – Measure into 50 Ω load into 1 MΩ load	(40 to 60) Ω (0.5 to 1.5) MΩ	0.082 % of reading 0.081 % of reading	
Input Capacitance – Measure	(5 to 50) pF	3.9 % of reading + 0.39 pF	
Waveform Generator Amplitude (Sine, Square, Triangle) into 50 Ω load into 1 MΩ load	10 Hz to 10 kHz 1.8 mVp-p to 2.5 Vp-p 1.8 mVp-p to 55 Vp-p	2.3 % of reading + 78 μV 2.3 % of reading + 78 μV	
Frequency (Sine, Square, Triangle)	10 Hz to 10 kHz	0.001 9 % of reading + 12 mHz	



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**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Angle Measuring Devices Protractors, Inclinerometers, Squares, Angle Gages <sup>7</sup>	0.005 6" to 5° (5 to 20)° (20 to 35)° (35 to 45)° (45 to 60)° (60 to 75)° (75 to 85)° 90°	6.5" 7.4" 9.4" 11.7" 18" 37" 111" 3.7"	10 in Sine Bar, Gage Blocks       Granite Master Square
Calipers and Micrometers <sup>1,7</sup> (Outside, Inside, Depth)	(0.01 to 1) in (1 to 9) in	13 μin (9 + 4L) μin	Gage Blocks
Calipers and Micrometers <sup>1,7</sup> (Outside, Inside, Depth)	(4 to 15) in (15 to 40) in	(10 + 4L) μin (14 + 4L) μin	Long Gage Blocks
Anvil Flatness <sup>1</sup>	Up to 4 in	5 μin	Optical Flats
Anvil Parallelism <sup>1</sup>	Up to 1 in	16 μin	Optical Parallels
Bore Gages <sup>7</sup>	(0.04 to 1) in (1 to 5) in	83 μin (82 + 1.9L) μin	Characterized Ring Gages
Dial/Digital Indicators, LVDT's, Gage Amplifiers <sup>7</sup>	Up to 1 in (1 to 2) in (2 to 6) in	(6.1 + 1.1L) μin (4.2 + 3L) μin (0.9 + 4.8L) μin	Pratt & Whitney Labmaster®
Single Axis Measurement – Outside <sup>7</sup>	Up to 1 in (1 to 7) in (7 to 12) in	(6 + 1L) μin (4.3 + 3.5L) μin (11 + 4L) μin	Pratt & Whitney Labmaster®
Single Axis Measurement – Outside <sup>7</sup>	(12 to 24) in	(1 + 5.8L) μin	Pratt & Whitney Supermicrometer®
Single Axis Measurement – Inside <sup>7</sup>	(0.04 to 1) in (1 to 2.5) in (2.5 to 10) in (10 to 14) in	(9 + 1L) μin (10 + 3L) μin (14 + 3L) μin (25 + 3L) μin	Pratt & Whitney Labmaster®
Micrometer Heads	Up to 1 in (1 to 2) in	29 μin 31 μin	Gage Amplifier, Gage Blocks
Height Measuring Equipment <sup>1,7</sup>	Up to 12 in (12 to 24) in	(63 + 2L) μin (37 + 4.2L) μin	Gage Blocks, Surface Plate
Parallelism & Straightness	Up to 36 in	89 μin	Gage Amplifier, Surface Plate
Crimp Tools – Crimp Height	Up to 1 in	0.001 in	Crimp Height Micrometer
Squareness <sup>7</sup>	90°	(160 + 4.8L) μin	Granite Square, Surface Plate, Gage Amplifier
Length Measuring Equipment – Linear Displacement <sup>7</sup>	Up to 12 ft	(1 + 2.1L) μin	Laser Interferometer

**Length – Dimensional Metrology**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Thread Wire Sets	(2 to 120) TPI (0.008 33 to 0.5) in	12 μin	Universal Length Measuring Machine
Cylindrical Plug Gages <sup>7</sup> (Outside Diameter)	Up to 5 in	(8.8 + 2.9L) μin	Universal Length Measuring Machine
Cylindrical Ring Gages <sup>7</sup> (Inside Diameter)	(0.04 to 0.5) in (0.5 to 1) in (1 to 3) in (3 to 11) in	(8.1 + 1.5L) μin (8.5 + 1L) μin (1.5 + 8.4L) μin (16.6 + 4.2L) μin	Universal Length Measuring Machine
Laser Micrometers <sup>7</sup>	(0.011 to 1) in	(13 + 1.8L) μin	Master Cylindrical Pin Gages
Rulers <sup>7</sup>	Up to 12 in (12 to 18) in	200 + 50L) μin (210 + 71L) μin	OGP Smartscope Flash 302 Measuring System
Thread Plug Gages <sup>7</sup> Pitch Diameter, 60 ° Thread	Up to 4 in	83 μin	Universal Length Measuring Machine, Thread Measuring Wires
Major Diameter	Up to 4 in	(8.8 + 2.9L) μin	
Thread Ring Gages Inner Pitch Diameter	Up to 4 in	83 μin	Thread Plug Uncertainty

**Mass and Mass Related**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Balances and Scales <sup>1,8</sup> (SI)	(1 to 5) g	40 μg	ASTM E617 Class 1 weights and internal calibration procedure utilized for the calibration of the weighing system.
	(5 to 10) g	59 μg	
	(10 to 20) g	89 μg	
	(20 to 50) g	0.15 mg	
	(50 to 100) g	0.31 mg	
	(100 to 150) g	0.35 mg	
	(150 to 250) g	0.64 mg	
	(250 to 300) g	0.69 mg	
Balances and Scales <sup>1,8</sup> (SI)	(300 to 320) g	0.7 mg	ASTM E617 Class 2 weights and internal calibration procedure utilized for the calibration of the weighing system.
	(1 to 5) g	63 μg	
	(5 to 10) g	87 μg	
	10 g to 10 kg	0.000 59 % of reading	
	(10 to 15) kg	0.000 44 % of reading	
	(15 to 20) kg	0.000 42 % of reading	
(20 to 31) kg	0.000 31 % of reading		

**Mass and Mass Related**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Balances and Scales <sup>1,8</sup> (SI)	(2 to 5) mg (5 to 10) mg (10 to 20) mg (20 to 50) mg (50 to 100) mg (100 to 200) mg (200 to 500) mg (0.5 to 1) g (1 to 2) g (2 to 5) g (5 to 10) g (10 to 20) g (20 to 50) g (50 to 100) g (100 to 200) g (200 to 210) g	51 µg 53 µg 57 µg 63 µg 70 µg 80 µg 92 µg 0.12 mg 0.15 mg 0.21 mg 0.29 mg 0.41 mg 0.70 mg 1.2 g 1.4 g 1.7 g	ASTM E617 Class 3 weights and internal calibration procedure utilized for the calibration of the weighing system.
Balances and Scales <sup>1,8</sup> (SI)	(1 to 2) g (2 to 5) g (5 to 10) g (10 to 20) g (20 to 50) g (50 to 100) g (100 to 150) g (150 to 200) g (200 to 210) g	0.13 mg 0.15 mg 0.17 mg 0.20 mg 0.28 mg 0.59 mg 0.65 mg 0.74 mg 0.78 mg	NIST Class S weights and internal calibration procedure utilized for the calibration of the weighing system.
Balances and Scales <sup>1,8</sup> Avoirdupois  SI	0.5 lb 1 lb (1 to 700) lb  227 g 454 g (0.454 to 318) kg	0.024 % of reading 0.018 % of reading 0.012 % of reading  0.024 % of reading 0.018 % of reading 0.012 % of reading	NIST Class F weights and internal calibration procedure utilized for the calibration of the weighing system.
Durometers <sup>7</sup> Spring Force Type A, B, E, O Type D, C, DO  Indenter Dimensions Length Angle Radius	Up to 100 Duro Up to 100 Duro  Up to 1 in Up to 40° Up to 5 in	0.57 Duro 0.51 Duro  (85 + 50L) µin 0.006° (440 + 50L) µin	Direct Verification per ASTM D2240-02B using Durometer Calibrator  OGP Smartscope Flash 302





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**Mass and Mass Related**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Force Measuring Equipment <sup>1</sup>	(0.5 to 100) lb	0.025 % of reading	NIST Class F Weights
Mass Determination (Metric)	10 kg 20 kg 25 kg	0.29 g 0.29 g 0.32 g	Echelon III
Mass Determination (Avoirdupois)	20 lb 25 lb 50 lb	0.000 64 lb 0.000 64 lb 0.000 71 lb	Echelon III
Absolute Pressure Devices (Pneumatic)	Up to 25 psia (25 to 500) psia	0.001 9 psi 0.006 8 % of reading	Ruska 7250xi Pressure Controller/Calibrator
Absolute Pressure Devices (Hydraulic)	(50 to 150) psia (150 to 15 000) psia	0.014 % of reading 0.013 % of reading	Ametek T150 Deadweight Tester w/ Ruska 7250xi Pressure Controller/Calibrator
Gage Pressure Devices (Pneumatic)	(-60 to -22) inH <sub>2</sub> O (-22 to 22) inH <sub>2</sub> O (22 to 60) inH <sub>2</sub> O (60 to 72) inH <sub>2</sub> O (72 to 804) inH <sub>2</sub> O	0.009 % of reading + 0.000 150 inH <sub>2</sub> O 0.002 2 inH <sub>2</sub> O 0.009 % of reading + 0.000 150 inH <sub>2</sub> O 0.006 7 inH <sub>2</sub> O 0.009 % of reading + 0.000 150 inH <sub>2</sub> O	DHI PPC4 Pressure Controller
Gage Pressure Devices (Pneumatic)	(-15 to 25) psig (25 to 500) psig	0.001 7 psi 0.006 5 % of reading	Ruska 7250xi Pressure Controller/Calibrator
Gage Pressure Devices (Hydraulic)	(50 to 150) psig (150 to 15 000) psig	0.012 % of reading + 0.012 psi 0.012 % of reading	Ametek T150 Deadweight Tester
Torque Measuring Devices <sup>1</sup> (Wrenches, Electronic, etc.)	(3.2 to 80) ozf·in (4 to 50) lbf·in (30 to 1 000) lbf·in (20 to 250) lbf·ft (60 to 600) lbf·ft	1.2 % of reading + 0.002 3 ozf·in 0.7 % of reading 0.4 % of reading 0.4 % of reading 0.37 % of reading	Torque Calibrator
Torque Calibration Systems (Analyzers, Transducers, etc.)	2.5 ozf·in to 50 lbf·ft	0.12 % of reading	Torque Wheels, NIST Class F Weights

**Thermodynamic**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment		
Relative Humidity – Source	(-10 to 15) °C		Thunder Scientific 2500 Two-Pressure Humidity Generator		
	(10 to 75) %RH	0.5 %RH			
	(75 to 95) %RH	0.65 %RH			
	(15 to 35) °C				
	(10 to 95) %RH	0.5 %RH			
	(35 to 70) °C				
Relative Humidity – Measure <sup>1</sup>	(10 to 60) °C		Vaisala Thermohygrometer		
	(10 to 90) %RH	1.3 %RH			
	SPRT/PRT/RTD Probes <sup>9</sup>	-195 °C		5.4 mK	Comparison to Fluke 1595A Super Thermometer, PRT, NBPLN <sub>2</sub>
	SPRT/PRT/RTD Probes <sup>9</sup>	-78 °C -38.8 °C		4.4 mK 4 mK	
SPRT/PRT/RTD Probes <sup>9</sup>	0.01 °C	2.9 mK	Triple Point of Water (Fixed Cell)		
SPRT/PRT/RTD Probes <sup>9</sup>	29.8 °C	3.3 mK	Comparison to Fluke 1595A Super Thermometer, PRT, Precision Bath		
	100 °C	3.9 mK			
	156 °C	7.6 mK			
	232 °C	8.2 mK			
	300 °C	8.8 mK			
	420 °C 500 °C	9.9 mK 14 mK			
Temperature – Measure <sup>1</sup>	(-195 to 0) °C	0.002 7 % of reading + 7.2 mK	Hart Scientific 5628 Secondary PRT, Black Stack		
	(0 to 660) °C	0.002 7 % of reading + 10 mK			
Temperature – Measure <sup>1</sup>	(660 to 1 200) °C	0.46 % of reading + 2.9 °C	Druck DPI 620 Calibrator, Geo Corp Type N Thermocouple Probe		



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**Time and Frequency**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Frequency Dissemination Source/Measure	10 MHz	5.8 nHz/Hz	Rubidium Standard
Rise Time – Measure	≥ 700 ps	140 ps	Tektronix TDS3052C Digital Oscilloscope
Stopwatches, Timers	Up to 599 s/month	58 ms/d	Timometer
AC Duty Cycle – Source <sup>1</sup> Square Wave < 3.3 Vp-p Freq: 0.1 Hz to 100 kHz	10 μs to 100 s (1 to 10) % Duty Cycle (10 to 49) % Duty Cycle 50 % Duty Cycle (51 to 90) % Duty Cycle (90 to 99) % Duty Cycle	0.62 % of reading + 78 ns 0.039 % of reading + 78 ns 0.001 6 % of reading + 78 ns 0.039 % of reading + 78 ns 0.62 % of reading + 78 ns	Fluke 5522A Multiproduct Calibrator

**DIMENSIONAL MEASUREMENT**

**2 Dimensional**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
2-D Measurements <sup>7</sup> Angle	(0 to 360)° Up to 2 in to angle (2 to 16) in to angle	0.007 2° (0.000 5L) + 0.006 2°	OGP Smartscope Flash 302 Measuring System utilized in the Dimensional Measurements of Customer Gages and Fixtures.
Perpendicularity	Up to 12 in (12 to 18) in	(120 + 48L) μin (123 + 71L) μin	
Radius	Up to 5 in	(440 + 50L) μin	

**3 Dimensional**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
3-D Measurements <sup>7</sup>	X-axis: Up to 12 in Y-axis: Up to 12 in Z-axis: Up to 10 in	(85 + 50L) μin (85 + 50L) μin (140 + 75L) μin	OGP Smartscope Flash 302 Measuring System utilized in the Dimensional Measurements of Customer Gages and Fixtures.
	X-axis: (12 to 18) in Y-axis: (12 to 18) in Z-axis: Up to 10 in	(120 + 71L) μin (120 + 71L) μin (140 + 75L) μin	

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ( $k=2$ ), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. 230 V maximum up to 100 kΩ; 1 kV maximum up to 1 MΩ; 5 kV maximum up to 1 TΩ.
3. As frequency deviates from the listed values, uncertainty may be higher than stated. If needed, contact laboratory for more information regarding uncertainties at frequency and range combinations other than the ones shown.
4. The uncertainties shown are for the most favorable conditions. There is an increase in uncertainty that corresponds to the laboratory's AC voltage and current uncertainties at different frequencies other than the ones shown. Power factors (PF) other than the one shown contribute to the power uncertainty. PF is related to the cosine of phase. Therefore, uncertainties track the laboratory's phase uncertainty closely at PF near one, but are magnified heavily as PF approaches zero. The lab may also report reactive power, apparent power, and power factor under this accreditation. If needed, contact laboratory for more information regarding uncertainties at frequency and power factor combinations other than the ones shown.
5. As frequency & amplitude deviate from the listed values, uncertainty may be higher than stated. If needed, contact laboratory for more information regarding uncertainties at frequency and range combinations other than the ones shown.
6. The stated uncertainty is the laboratory's ability to source a fast rise pulse that is approximately 250 ps. In the typical application of measuring rise time of an oscilloscope, this value is one of the contributing factors, but other factors are derived from the DUT. The known source rise time is mathematically removed from the total measured rise time measured on the DUT.
7. " = arc-second; L = length in inches;
8. The CMC for scales and balances is highly dependent upon the resolution of the unit under test. The CMC presented here does not include the resolution of the unit under test. The resolution will be included in the reported measurement uncertainty at the time of calibration.
9. NBPLN<sub>2</sub> = boiling point of liquid nitrogen.
10. The legal entity for this location is Transeat, Inc.
11. This scope is formatted as part of a single document including Certificate of Accreditation No. AC-2489.04.



Jason Stine, Vice President